

FAIRCHILD
SEMICONDUCTOR®

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FDFS6N754

Integrated N-Channel PowerTrench® MOSFET and Schottky Diode 30V, 4A, 56mΩ

Features

- Max $r_{DS(on)}$ = 56mΩ at $V_{GS} = 0V$, $I_D = 4A$
Max $r_{DS(on)}$ = 75mΩ at $V_{GS} = 4.5V$, $I_D = 3.5A$
- $V_F < 0.45V @ 2A$
 $V_F < 0.28V @ 100mA$
- Schottky and MOSFET incorporated into single power surface mount SO-8 package
- Electrically independent Schottky and MOSFET pinout for design flexibility
- Low Gate Charge ($Q_g = 4nC$)
- Low Miller Charge



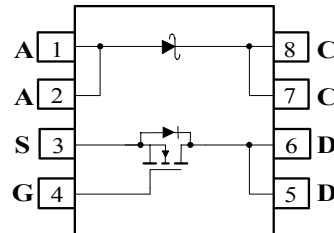
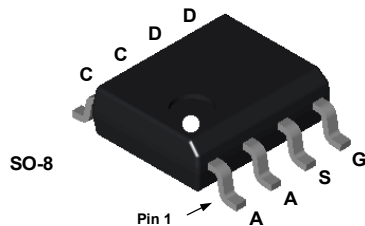
General Description

The FDFS6N754 combines the exceptional performance of Fairchild's PowerTrench MOSFET technology with a very low forward voltage drop Schottky barrier rectifier in an SO-8 package.

This device is designed specifically as a single package solution for DC to DC converters. It features a fast switching, low gate charge MOSFET with very low on-state resistance. The independently connected Schottky diode allows its use in a variety of DC/DC converter topologies.

Applications

- DC/DC converters



MOSFET Maximum Ratings $T_A = 25^\circ C$ unless otherwise noted

Symbol	Parameter	Rated	Units
V_{DS}	Drain to Source Voltage	30	V
V_{GS}	Gate to Source Voltage	± 20	V
I_D	Drain Current -Continuous (Note 1a)	4	A
	-Pulsed	20	
P_D	Power Dissipation for Dual Operation	2	W
	Power Dissipation for Single Operation (Note 1a)	1.6	
V_{RRM}	Schottky Repetitive Peak Reverse Voltage	20	V
I_O	Schottky Average Forward Current (Note 1a)	2	A
T_J, T_{STG}	Operating and Storage Temperature	-55 to 150	$^\circ C$

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	78	$^\circ C/W$
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	40	$^\circ C/W$

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDFS6N754	FDFS6N754	SO-8	330mm	12mm	2500 units

Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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Off Characteristics

BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$, referenced to 25°C		24.5		$\text{mV}/^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24\text{V}$ $V_{GS} = 0\text{V}$ $T_J = 125^\circ\text{C}$			1 20	μA
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$			± 100	nA

On Characteristics (Note 2)

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1	1.7	2.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$, referenced to 25°C		-4.2		$\text{mV}/^\circ\text{C}$
$r_{DS(on)}$	Drain to Source On Resistance	$V_{GS} = 10\text{V}, I_D = 4\text{A}$		42	56	m Ω
		$V_{GS} = 4.5\text{V}, I_D = 3.5\text{A}$		53	75	
		$V_{GS} = 10\text{V}, I_D = 4\text{A}$, $T_J = 125^\circ\text{C}$		61	81	
g_{FS}	Forward Transconductance	$V_{DS} = 5\text{V}, I_D = 4\text{A}$		10		S

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = 15\text{V}, V_{GS} = 0\text{V}$, $f = 1.0\text{MHz}$		225	299	pF
C_{oss}	Output Capacitance			80	107	pF
C_{rss}	Reverse Transfer Capacitance			42	63	pF
R_G	Gate Resistance			5.1		Ω

Switching Characteristics (Note 2)

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 15\text{V}, I_D = 1\text{A}$ $V_{GS} = 10\text{V}, R_{GS} = 6\Omega$		6	12	ns
t_r	Rise Time			8	16	ns
$t_{d(off)}$	Turn-Off Delay Time			20	32	ns
t_f	Fall Time			2	10	ns
$Q_{g(TOT)}$	Total Gate Charge at 10V	$V_{DS} = 15\text{V}$, $I_D = 4\text{A}$		4	6	nC
$Q_{g(5)}$	Total Gate Charge at 5V			2	3	nC
Q_{gs}	Gate to Source Gate Charge			0.6		nC
Q_{gd}	Gate to Drain "Miller" Charge			1		nC

Drain-Source Diode Characteristics and Maximum Ratings

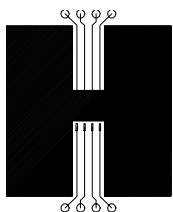
V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{V}, I_S = 1.3\text{A}$ (Note 2)		0.8	1.2	V
t_{rr}	Reverse Recovery Time	$I_F = 4\text{A}, di/dt = 100\text{A}/\mu\text{s}$		13	20	ns
Q_{rr}	Reverse Recovery Charge	$I_F = 4\text{A}, di/dt = 100\text{A}/\mu\text{s}$		4	6	nC

Schottky Diode Characteristics

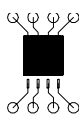
V_R	Reverse Breakdown Voltage	$I_R = -1\text{mA}$	-30			V
I_R	Reverse Leakage	$V_R = -10\text{V}$	$T_J = 25^\circ\text{C}$	39	250	μA
			$T_J = 125^\circ\text{C}$	18		mA
V_F	Forward Voltage	$I_F = 100\text{mA}$	$T_J = 25^\circ\text{C}$	225	280	mV
			$T_J = 125^\circ\text{C}$	140		
		$I_F = 2\text{A}$	$T_J = 25^\circ\text{C}$	364	450	
			$T_J = 125^\circ\text{C}$	290		

Notes:

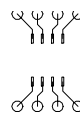
1: $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 78°C/W when mounted on a 0.5in² pad of 2 oz copper



b) 125°C/W when mounted on a 0.02 in² pad of 2 oz copper



c) 135°C/W when mounted on a minimum pad

Scale 1 : 1 on letter size paper

2: Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%.

